

Search Notes

Application/Control No.

10/812,197

Examiner

Patrick J. Lee

Applicant(s)/Patent under
Reexamination

DUDEK ET AL.

Art Unit

2878

SEARCHED

Class	Subclass	Date	Examiner
250	208.1, 214A, 214.1, 552	11/15/2006 11/20/2006	PL
257	222, 225	↓	PL
257	257-258	↓	PL
257	290-291	↓	PL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East (see attached) - USPAT, US-PGPUB, EPO, JPO, DERWENT	11/15/2006	PL
East (see attached) - USPAT, US-PGPUB, EPO, JPO, DERWENT	11/20/2006	PL